

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/909,550 | Applicant(s)/Patent Under Reexamination LIMAYE ET AL. | |
| | Examiner Andrew C Lee | Art Unit 2664 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-6,654,341 B1 | 11-2003 | Chi et al. | 370/216 |
| | B | US-6,608,836 B2 | 08-2003 | Mao et al. | 370/419 |
| | C | US-6,725,401 B1 | 04-2004 | Lindhorst-Ko, Gwenda | 714/47 |
| | D | US-6,324,162 B1 | 11-2001 | Chaudhuri, Sid | 370/225 |
| | E | US-6,154,296 | 11-2000 | Elahmadi et al. | 398/83 |
| | F | US-5,537,393 | 07-1996 | Shioda et al. | 370/223 |
| | G | US-6,717,953 B1 | 04-2004 | Heuer et al. | 370/466 |
| | H | US-5,923,646 | 07-1999 | Mandhyan, Indur B. | 370/254 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.